

Notice of References Cited	Application/Control No. 10/556,455		Applicant(s)/Patent Under Reexamination CHATting ET AL.	
	Examiner Eric Rush		Art Unit 2624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,385,628	05-2002	Massarsky, Yefim	715/502
*	B	US-2007/0019885	01-2007	Chatting et al.	382/289
*	C	US-2005/0100243	05-2005	Shum et al.	382/276
*	D	US-2003/0206171	11-2003	Kim et al.	345/473
*	E	US-5,960,099	09-1999	Hayes et al.	382/118
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP0990979A1	05-2000	France	Vachette et al.	
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Takayuki Fujiwara, Takeshi Nishihara, Masafumi Tominaga, Kunihiro Kato, Kazuhito Murakami, and Hiroyasu Koshimizu, "On the Detection of Feature Points of 3D Facial Image and Its Application to 3D Facial CARicature", 3-D Digital Imaging and Modeling, 1999, Proceedings, Second International Conference on Ottawa Ont., Canada 4 - 8 October 1999, pages
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.